

Notice of References Cited	Application/Control No. 10/616,266	Applicant(s)/Patent Under Reexamination IKAWA ET AL.	
	Examiner Tawfik Goma	Art Unit 2627	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,905,255	05-1999	Wakabayashi et al.	250/201.5
*	B	US-5,706,272	01-1998	Ezawa, Hiroshi	720/676
*	C	US-2002/0071189	06-2002	Ohno, Takehide	359/813
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	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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